Search Notes

Application/Control No.	Applicant(s)/Patent une Reexamination	der	
10/736,574	SAKAIDA, HIDEYUKI	SAKAIDA, HIDEYUKI	
Examiner	Art Unit		
Sherali Ishrat	2624		

SEARCHED				
Class	Subclass	Date	Examiner	
382	162-167 274- 275 254	7/16/2007	IS	
358	515-517	7/16/2006	IS	
	1.9			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
IEEE, EAST	7/16/2007	ıs	